Notice of References Cited 10/784,116 Reexamination WINKLER ET A Examiner Art Unit

10/784,116 WINKLER ET AL.

Examiner Art Unit

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Applicant(s)/Patent Under

U.S. PATENT DOCUMENTS

Application/Control No.

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-3,874,646	04-1975	Vernier, Pierre	267/140.13
	В	US-4,415,391	11-1983	Reid, Glenn J.	156/187
	С	US-4,761,925	08-1988	Fukahori et al.	52/167.7
	D	US-5,947,457 a	09-1999	Swanson et al.	267/140.14
	Ε	US-6,250,615 b1	06-2001	Leibach, Markus	267/140.13
	F	US-6,485,005 b1	11-2002	Tewani et al.	267/140.13
	G	US-6,793,206 b2	09-2004	Reh et al.	267/140.13
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			W
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R	,				
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	· ·

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.